



## **LTEC Corporation**

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# SiC SBD (2000V): Infineon G5 IDYH25G200C5 Overview and Structure Analysis Report



Package



SiC SBD die

Infineon, a leading manufacturer of power devices, has expanded its CoolSiC portfolio to the 2kV class, targeting applications using high-voltage power supplies, for which demand is expected to grow in the future, and released the market's first 2000V SiC SBD in October 2024 (until now, 600-1200V products have been the mainstream). The features of this product include high voltage, high speed operation, and improved current density due to high efficiency, which allows for simplified design and reduced system costs. We have now released the following report, which clarifies the structure and features of this product.

#### **Product features**

**Overview** 

- Product type: IDYH25G200C5 VRRM = 2000V, IF = 77A
- Released date: October 2024
- Application: Solar inverter, EV charging system
  Datasheet URL: <u>https://www.infineon.com/dgdl/Infineon-IDYH25G200C5-DataSheet-v01\_00-EN.pdf?fileId=8ac78c8c914a3ac801917f09d5c23976</u>

### Analysis Results (Please refer to pages 2 and 4 for the tables of contents)

- (1) Overview Analysis Report (13pages)
- (2) Structure Analysis Report (50pages)
- XT technology own by Infineon is used as the die attach material, which reduces the thermal resistance of the device. This technology is also used in Gen2 CoolSiC.
- The diode cell of this product has a hexagonal type MPS (Merged PiN Schottky) structure.
- Comparison with the company's G5 1200V product confirmed that the Epi thickness and die outer periphery structure (outer periphery width, JTE and GR structure) are different.
- (3) Electrical characteristics Analysis Report (In planning)
- IF-VF vs. temperature, capacitance(Cj), and breakdown voltage, etc.

#### **Report price**

#### Delivered one week after order placement Please contact us for report pricing.

LTEC Corporation US Representative Office <u>www.ltec-biz.com/en/</u> 2310 Homestead Rd, C1 #231 Los Altos, CA 94024 Phone: +1-(650) 382-1181 Contact2@ltec.biz

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## **Excerpt from (1) Overview Analysis Report**

#### Table1-1: Device summary

Device	SiC SBD (VRRM=2000V, IF = 77A (Tc=25°C))		
Manufacturer	Infineon Technologies AG (Germany)		
Product name	IDYH25G200C5		
Package type	TO-247-4		
Package marking	D2520C5 H 2335		
Die configuration	SiC SBD x1		
Die size	mm x mm = mm <sup>2</sup>		
SiC SBD Die manufacturing process	SiC wafer, Schottky metal, top metal anode		
Application	<ul><li>String 3-phase inverter</li><li>EV Charging</li></ul>		

**Device summary** 

Tc=25°C	1200V IDW30G120C5B	2000V IDYH25G200C5	
Die size (mm x mm = mm <sup>2</sup> )			
Active array area (mm <sup>2</sup> )	<b>U</b> . 1		
Forward current $I_F$ (A)	87	77	
Forward voltage V <sub>F</sub> (Typ.) (V)	1.4 (I <sub>F</sub> = 30A)	1.5 (I <sub>F</sub> = 25A)	
Forward Resistance: RF (mΩ) / Per Area:RF x AA (mΩ • mm²)			
Epi layer thickness (μm)			

Comparison with the company's G5 1200V product (Die size, active area, etc.)



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